		Application/Control No.		Applicant(s)/Pat	Applicant(s)/Patent under Reexamination	ion
Issue Classification	ntion	10693494		ISHIKAWA ET AL.	نـ	
		Examiner		Art Unit		
		Dinh, Jack		2873		
	ORIGINAL		INTE	RNATIONAL	INTERNATIONAL CLASSIFICATION	N
CLASS		SUBCLASS	CLAIMED	ED	NON-CLAIMED	AIMED
359	622		G 0 2 B G 0 3 B B	27 /10		
CROSS	CROSS REFERENCE(S)	(S)				
CLASS SUBCL	SUBCLASS (ONE SUBCLASS	ASS PER BLOCK)				
359 619	621 6	626 455 456				
JACK DINH Jadul (Assistant Examiner)	08/19/06 (Date)	Chesma			Total Claims Allowed: 18	s Allowed:
Kegal Instruments Examiner)	State)	Loha Ben Primary Examiner (Primary Examiner	g/λ	8/20/06	O.G. Print Claim(s) 1	O.G. Print Figure 1

U.S. Patent and Trademark Office

Part of Paper No. 0806